

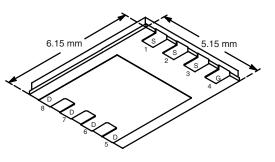
RoHS

COMPLIANT

Vishay Siliconix

N-Channel 25-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)			
25	0.0046 at V _{GS} = 10 V	40	13 nC			
	0.0062 at V_{GS} = 4.5 V	40	13110			



PowerPAK SO-8

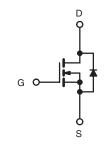
Bottom View

FEATURES

- Halogen-free
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested

APPLICATIONS

- · Low-Side Switch
- Server, VRM



Ordering Information: SiR436DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	25	V	
Gate-Source Voltage		V _{GS}	± 20	V	
	T _C = 25 °C		40 ^a		
Continuous Drain Current (T 150 °C)	T _C = 70 °C		40 ^a		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	25 ^{b, c}	٨	
	T _A = 70 °C		20 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	80		
Avalanche Current	L = 0.1 mH	I _{AS}	40		
Avalanche Energy		E _{AS}	80	mJ	
Continuous Course Drain Diada Current	T _C = 25 °C		40 ^a	A	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	4.1 ^{b, c}	A	
	T _C = 25 °C		50		
Maximum Dawar Dissination	T _C = 70 °C		32	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	5 ^{b, c}	vv	
	T _A = 70 °C		3.2 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS

Parameter		Symbol Typical		Maximum	Unit		
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	20	25	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	2.0	2.5			

Notes:

a. Based on $T_C = 25$ °C. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under Steady State conditions is 70 °C/W.

c. t = 10 s.

d. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

SiR436DP

Vishay Siliconix



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	25			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		24		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	i _D = 250 μA		- 5.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1		3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 25 V, V_{GS} = 0 V$			1	— μΑ	
		V_{DS} = 25 V, V_{GS} = 0 V, T_{J} = 55 °C			5		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	50			Α	
Drain-Source On-State Resistance ^a		V _{GS} = 10 V, I _D = 20 A		0.0038	0.0046		
	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 18 A		0.005	0.0062	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 20 A		60		S	
Dynamic ^b			I		<u> </u>		
Input Capacitance	C _{iss}			1715		pF	
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		425			
Reverse Transfer Capacitance	C _{rss}			170			
-	0	V _{DS} = 12.5 V, V _{GS} = 10 V, I _D = 20 A		31	47	nC	
Total Gate Charge	Qg			13	20		
Gate-Source Charge	Q _{gs}	V_{DS} = 12.5 V, V_{GS} = 4.5 V, I_{D} = 20 A		4.5			
Gate-Drain Charge	Q _{gd}			3.9			
Gate Resistance	R _g	f = 1 MHz		1.0	2.0	Ω	
Turn-On Delay Time	t _{d(on)}			22	40	ns	
Rise Time	t _r	V_{DD} = 12.5 V, R_L = 12.5 Ω		11	25		
Turn-Off Delay Time	t _{d(off)}	$\rm I_D \cong 1.0$ A, $\rm V_{GEN}$ = 4.5 V, $\rm R_g$ = 1 Ω		32	50		
Fall Time	t _f			8	25		
Turn-On Delay Time	t _{d(on)}			13	25		
Rise Time	t _r	V_{DD} = 12.5 V, R_L = 12.5 Ω		8	15		
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ 1.0 A, V_GEN = 10 V, R_g = 1 Ω		30	40		
Fall Time	t _f			9	15		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			40	A	
Pulse Diode Forward Current	I _{SM}				80	~	
Body Diode Voltage	V _{SD}	I _S = 4.1 A, V _{GS} = 0 V		0.75	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			28	56	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 4.1 A, dl/dt = 100 A/μs, T _{.1} = 25 °C		20	40	nC	
Reverse Recovery Fall Time	t _a	$F = 4.1 \text{ A}, \text{ unut} = 100 \text{ A/}\mu\text{s}, 1\text{ J} = 25 \text{ C}$		15		– ns	
Reverse Recovery Rise Time	t _b	1		13			

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

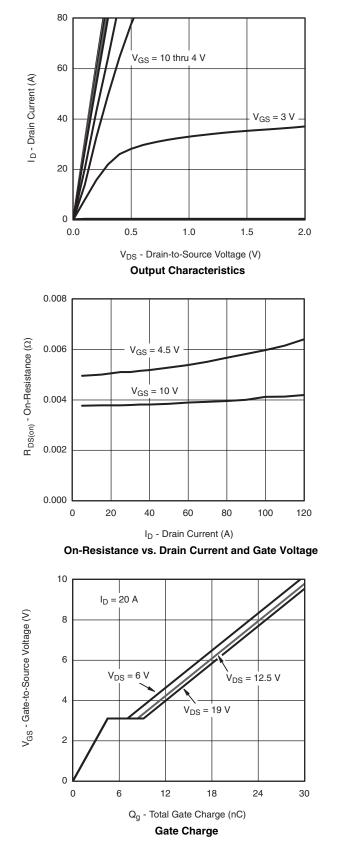
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

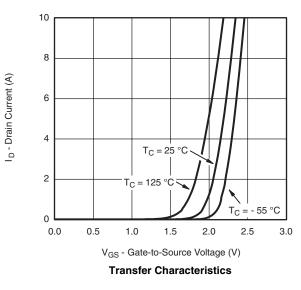


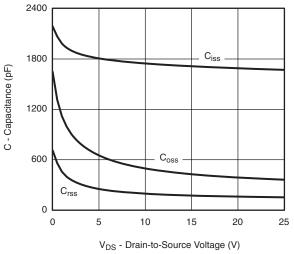
SiR436DP

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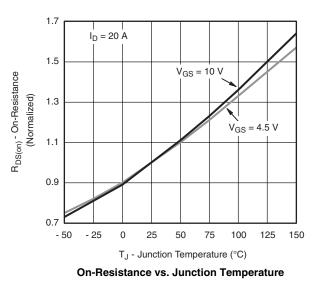
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted









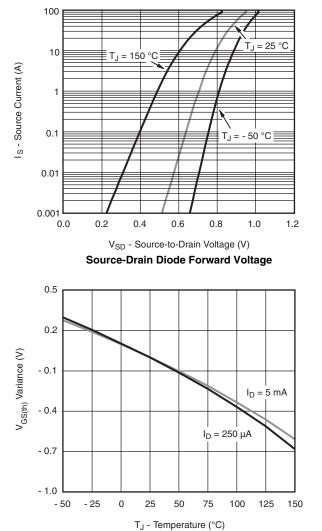


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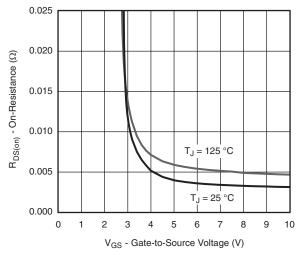
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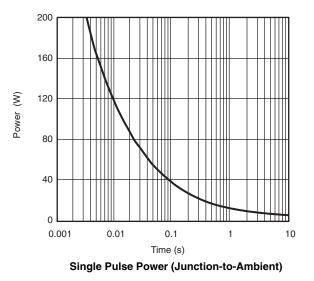
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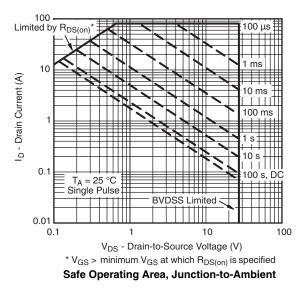






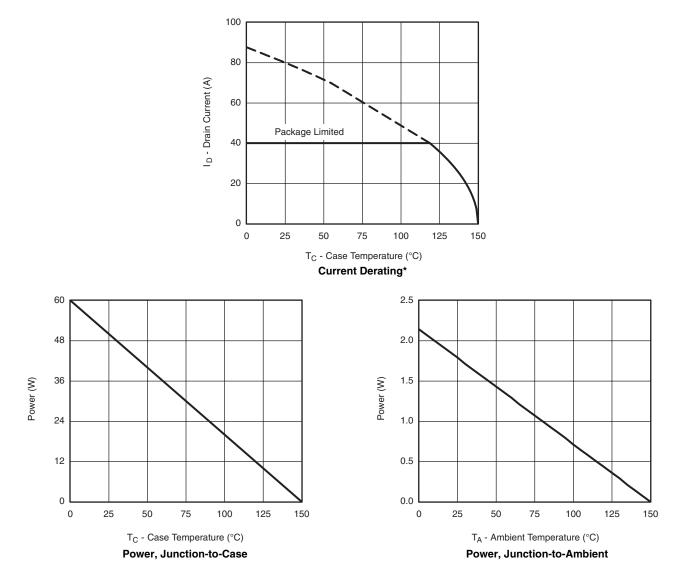
On-Resistance vs. Gate-to-Source Voltage







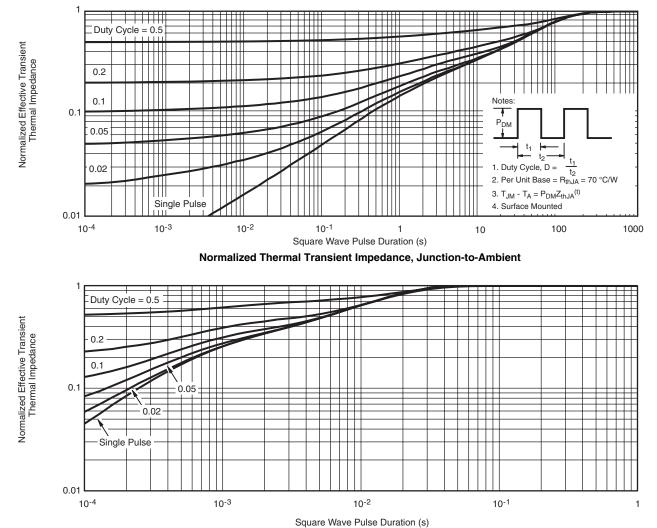
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* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?69011.



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